Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/551,268	MATSUMOTO ET AL.	
Examiner	Art Unit	
Helen L. Pezzuto	1713	

SEARCHED				
Class	Subclass	Date	Examiner	
526	271,317.1			
	318.2			
	318.4			
•	318.5,319			
	321,329.6			
	332, 333			
106	823	9/28/2007	HP	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
- N				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STIC STN search	9/4/2007	• нр		
West, inventors search	9/28/2007	НР		